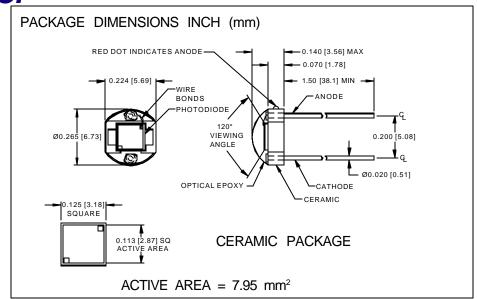
**PHOTONIC** Silicon Photodiode, U.V. Enhanced Photoconductive **DETECTORS INC.** Type PDU-C113





#### **FEATURES**

- High speed
- Low capacitance
- U.V. enhanced
- Low dark current

## **DESCRIPTION**

The **PDU-C113** is a silicon, PIN planar diffused, U.V. enhanced photodiode. Ideal for high speed photoconductive applications. Packaged on a two lead ceramic substrate with a clear U.V. transmitting epoxy glob top.

### **APPLICATIONS**

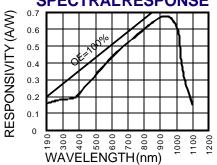
- U.V. exposure meter
- Water purification
- Fluorescence
- U.V. A & B meters

# ABSOLUTE MAXIMUM RATING (TA=25°C unless otherwise noted)

SYMBOL	PARAMETER	MIN	MAX	UNITS
V <sub>BR</sub>	Reverse Voltage		30	V
T <sub>STG</sub>	Storage Temperature	-40	+100	⊙C
To	Operating Temperature Range	-40	+90	⊙C
Ts	Soldering Temperature*		+240	∘C
IL	Light Current		500	mA

<sup>\*1/16</sup> inch from case for 3 secs max

# **SPECTRALRESPONSE**



## ELECTRO-OPTICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Isc	Short Circuit Current	H = 100 fc, 2850 K	90	110		μΑ
ΙD	Dark Current	H = 0, V <sub>R</sub> = 5 V		10	50	nA
RsH	Shunt Resistance	H = 0, V <sub>R</sub> = 10 mV	100	250		MΩ
TC Rsh	RsH Temp. Coefficient	H = 0, V <sub>R</sub> = 10 mV		-8		%/℃
Сл	Junction Capacitance	$H = 0$ , $V_R = 5 V^{**}$		130		рF
λrange	Spectral Application Range	Spot Scan	250		1100	nm
R	Responsivity	$V_{R} = 0 \text{ V}, \ \lambda = 254 \text{ nm}$	.12	.18		A/W
V <sub>BR</sub>	Breakdown Voltage	Ι = 10 μΑ	15	25		V
NEP	Noise Equivalent Power	V <sub>R</sub> = 5 V @ Peak		2.2x10 <sup>-14</sup>		W/√ <sub>Hz</sub>
tr	Response Time	RL = 1 KΩ V <sub>R</sub> = 5 V		58		nS

Information in this technical data sheet is believed to be correct and reliable. However, no responsibility is assumed for possible inaccuracies or omission. Specifications are subject to change without notice. \*\*f=1 MHz [FORM NO. 100-PDU-C113 REV A]